

GCMS020B120S1-E1

V _{DS}	1200 V
R _{DS,on}	18 mΩ
I _{D (TC=25C)}	113 A
T _J ,max	175°C

1200V SiC COPACK Power Module

Features

- High speed switching SiC MOSFETs
- Freewheeling SiC SBD with zero reverse recovery
- · Simple to drive
- Kelvin reference for stable operation

Benefits

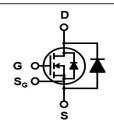
- Low switching losses
- Low junction to case thermal resistance
- · Very rugged and easy mount
- Direct mounting to heatsink (isolated package)
- Lower Q_{RR} at high temperature

Applications

- Photovoltaic Inverter
- · Battery charger
- Server power supplies
- · Energy storage system

Package





- (1) S_G (Driver Source)
- (2) G (Gate)
- (3) D (Drain)
- (4) S (Source)

Part #	Package	Marking
GCMS020B120S1-E1	SOT-227	GCMS020B120S1-E1



Absolute Maximum Ratings

Characteristics	Symbol	Conditions	Values	Unit	
Drain-Source Voltage	V _{rated}	V _{GS} =0V, I _D =200μA	1200	V	
	ı	T _C =25°C, V _{GS} =20V	113		
Continuous Drain Current	I _{DS}	T _C =100°C, V _{GS} =20V	81		
	I _{SD} *	T _C =25°C, V _{GS} =20V	143	Α	
Schottky Diode DC Current	I _F	T _C =25°C, V _{GS} =-5V	106		
Pulsed Drain Current	I _{DS,pulse} **	T _C =25°C, V _{GS} =20V	250		
Gate Source Voltage	V_{GSmax}		-10/25	V	
Gate Source voltage	V_{GSop}	Recommended operational	-5/20	V	
Power Dissipation - MOSFET	P _{tot}	T _C =25°C	395	W	
Operating & Storage Temperature	T _J , T _{storage}	Continuous	-55175	°C	

 $^{{}^*{\}rm I}_{\rm SD}$ maximum continous current for parallel SBD and MOSFET body diode assuming maximum Rth $_{\rm JC}$ of SBD

^{**}Pulse width is limited by T_{Jmax}

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Static Electrical Characteristics, at T_J=25°C, unless otherwise specified

Characteristics	Symbol	nbol Conditions		Values		
Cital acteristics	Symbol		min.	typ.	max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V_{GS} =0V, I_D =1mA	1200	-	-	V
Zoro Coto Voltago Droin Current		V _{DS} =1200V, V _{GS} =0V	-	5	100	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =1200V, V _{GS} =0V, T _J =175°C	-	159	750	μA
Cata Sauraa Laakaga Currant	I _{GSS+}	V _{GS} =20V, V _{DS} =0V	-	10	1000	nΛ
Gate-Source Leakage Current	I _{GSS-}	V _{GS} =-5V, V _{DS} =0V	-	-10	-1000	nA
Cata Threshold Voltage	V _{GS(th)}	V _{GS} =V _{DS} , I _D =20mA	1.8	2.8	4	V
Gate Threshold Voltage		$V_{GS}=V_{DS}$, $I_D=20$ mA, $T_J=175$ °C	-	1.7	-	
		V _{GS} =20V, I _D =50A	-	18.1	28	
Danier Courses On Braintana	R _{DSon}	V _{GS} =20V, I _D =25A	-	17.6	26	mΩ
Drain-Source On-Resistance		V _{GS} =20V, I _D =50A, T _J =125°C	-	24	-	
		V _{GS} =20V, I _D =50A, T _J =175°C	-	30	-	
Transconductance	g _{fs}	V _{DS} =20V, I _D =50A	-	25	-	S
Internal Gate Resistance	$R_{G(int)}$	f=1MHz, V _{AC} =25mV, D-S Short	-	0.8	-	Ω

AC Electrical Characteristics, at T_J=25°C, unless otherwise specified

Characteristics	Cumbal	Conditions	Values			Unit
Cital acteristics	Symbol Conditions	min.	typ.	max.	Unit	
Input Capacitance	C _{ISS}	V _{GS} =0V	-	5279	-	
Output Capacitance	C _{OSS} **	V _{DS} =1000V	-	436	-	pF
Reverse Transfer Capacitance	C _{RSS}	f=200kHz	-	19	-	
Coss Stored Energy	E _{oss} ***	V _{AC} =25mV	-	265	-	μJ
Turn-On Switching Energy	E _{ON}		-	0.57	-	mJ
Turn-Off Switching Energy	E _{OFF}	V_{DD} =800V, I_{DS} =50A, $R_{G(ext)}$ =3.9 Ω ,	-	0.27	-	1113
Turn-On Delay Time	t _{D(on)}	V _{GS} =-5/+20V, L=273μH,	-	25	-	
Rise Time	t _R	FWD=GCMS020B120S1-E1	-	8	-	1
Turn-Off Delay Time	t _{D(off)}	7	-	46	-	ns
Fall Time	t _F	1	-	25	-	
Total Gate Charge	Q_{G}	V 000V I 50A	-	215	-	
Gate to Source Charge	Q_{GS}	-V _{DD} =800V, I _{DS} =50A -V _{GS} =-5/20V	-	76	-	nC
Gate to Drain Charge	Q_{GD}	7 V GS 0/20 V	-	43	-	

^{**} C_{OSS} is combination of MOSFET C_{OSS} and diode junction capacitance

Freewheeling Diode Characteristics, at T_J=25°C, unless otherwise specified

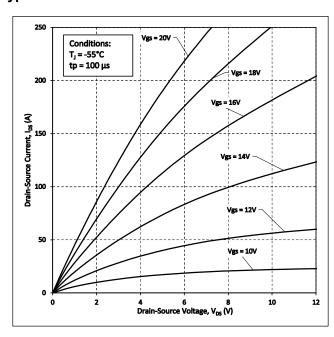
Characteristics	Symbol Conditions		Values			Unit
Cildiacteristics	Symbol	min.	typ.	max.	Oilit	
Diode Forward Voltage		V _{GS} =-5V, I _S =50A	-	1.49	1.7	V
	V_{SD}	V _{GS} =-5V, I _S =50A, T _J =175°C	-	2.13	-	,
Reverse Recovery Time	t _{RR}		-	19	-	ns
Reverse Recovery Charge	Q_{RR}	I _S =50A, V _R =800V, V _{GS} =-5V	-	805	-	nC
Peak Reverse Recovery Current	I _{RRM}	di/dt=8.3A/ns	-	70	-	Α
Reverse Recovery Energy	E _{RR}		-	0.49	-	mJ

^{***} $E_{\mbox{\scriptsize OSS}}$ is calculated from $C_{\mbox{\scriptsize OSS}}$ curve

Thermal and Package Characteristics, at T_j =25 °C, unless otherwise specified

Characteristics	Symbol Conditions		Values			Unit
Cilai acteristics	Symbol	min.	typ.	max.	Oilit	
Thermal resistance, junction-case	R _{thJC}	MOSFET only	-	0.31	0.38	°C/W
Thermal resistance, junction-case	R _{thJC}	Schottky diode only	-	0.38	0.46	C/VV
Mounting torque	M _d	M4-0.7 screws	1.1	-	1.5	N-m
Terminal connection torque	M _{dt}	M4-0.7 screws	-	1.1	1.3	IN-III
Package weight	W _t		-	32	-	g
Isolation voltage	V _{ISOL}	I _{ISOL} < 1mA, 50/60 Hz, 2 s	4000	-	-	V

Typical Performance



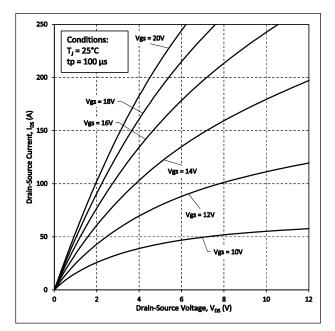
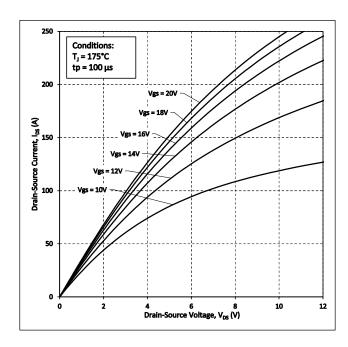


Figure 1. Output Characteristics $T_J = -55$ °C

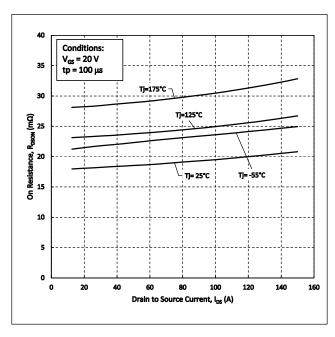
Figure 2. Output Characteristics $T_J = 25^{\circ}C$

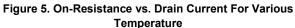


Conditions: I_{DS} = 50 A V_{GS} = 20 V 1.6 tp = 100 μs RDSON 50A RDSON 25A රි 0.6 0.4 Normalized to RDSON ID=50A @ 25°C 0.0 -25 125 150 175 -50 100 50 Junction Temperature, T, (°C)

Figure 3. Output Characteristics T_J = 175°C

Figure 4. Normalized On-Resistance vs. Temperature





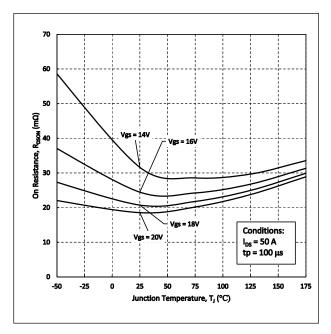


Figure 6. On-Resistance vs. Temperature For Various
Gate Voltages

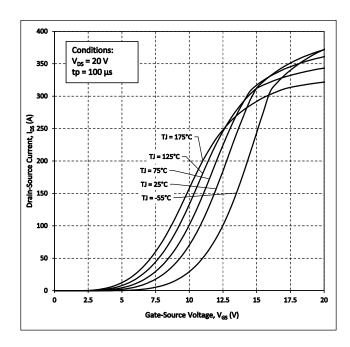


Figure 7. Transfer Characteristic for Various Junction Temperatures

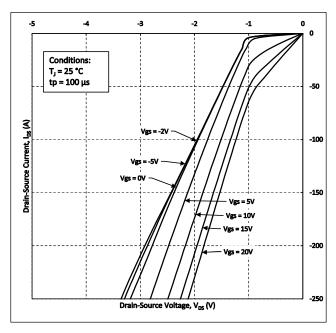


Figure 9. Freewheeling Diode Characteristics at $T_J = 25^{\circ}\text{C}$

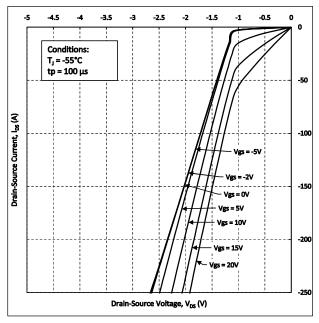


Figure 8. Freewheeling Diode Characteristics at $T_J = -55^{\circ}\text{C}$

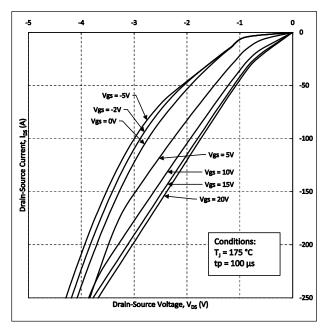
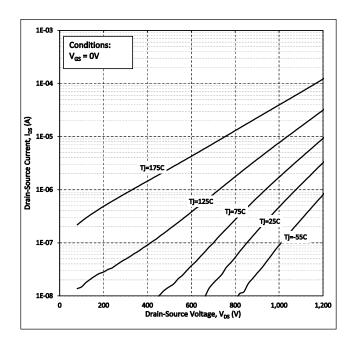


Figure 10. Freewheeling Diode Characteristics at T_J = 175°C



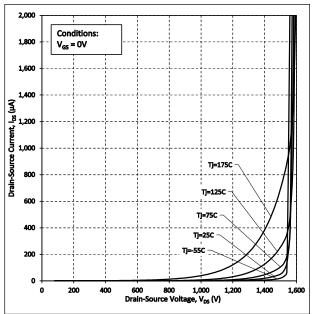


Figure 11. IDSS vs. Temperature

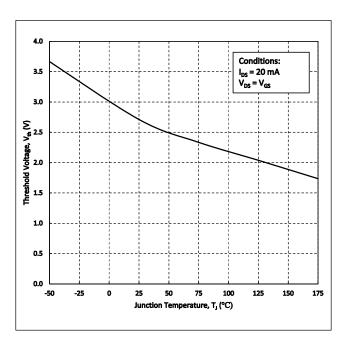


Figure 12. IDSS vs. Temperature

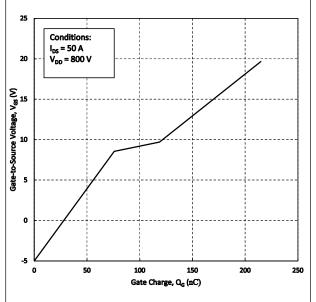
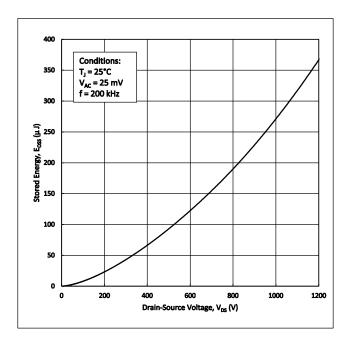


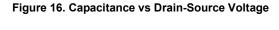
Figure 13. Threshold Voltage vs. Temperature

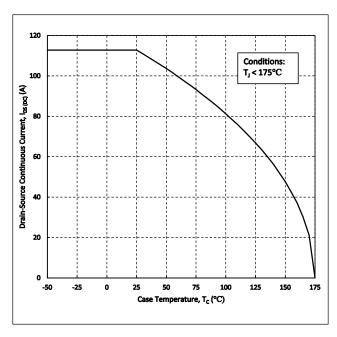
Figure 14. Gate Charge Characteristics



10,000 1,000 Coss Capacitance (pF) 100 Crss 10 Conditions: T_J = 25°C V_{AC} = 25 mV f = 200 kHz 1200 200 600 800 1000 Drain-Source Voltage, V_{DS} (V)

Figure 15. Output Capacitor Stored Energy







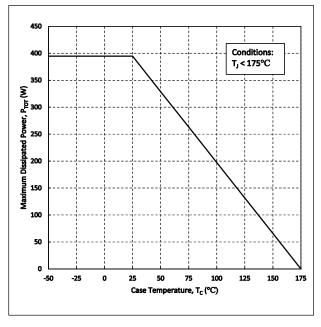


Figure 18. Maximum Power Dissipation Derating vs
Case Temperature

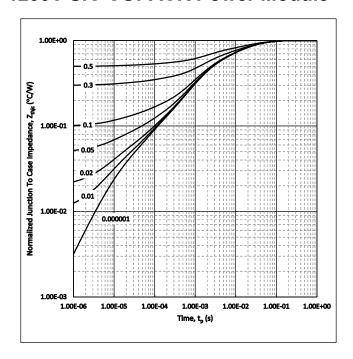


Figure 19. Transient Thermal impedance (Junction to Case)

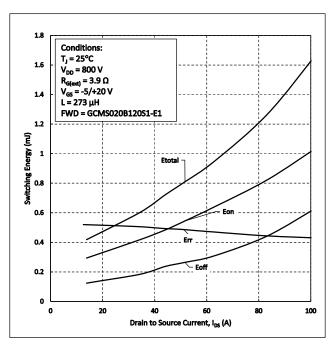


Figure 21. Clamped Inductive Switching Energy vs. Drain Current

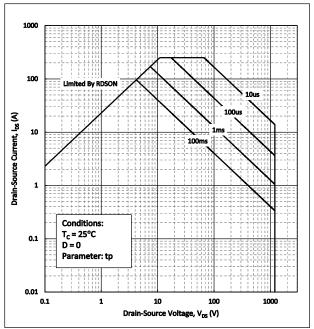


Figure 20. Safe Operating Area

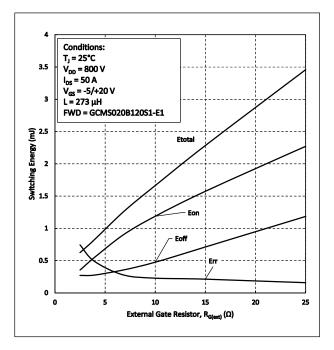


Figure 22. Clamped Inductive Switching Energy vs. $R_{\text{G(ext)}} \label{eq:RG(ext)}$

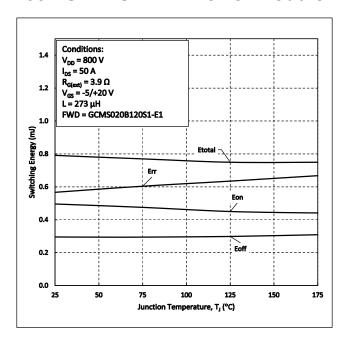


Figure 23. Clamped Inductive Switching Energy vs.
Temperature

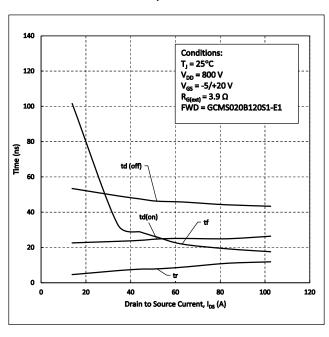


Figure 24. Switching Times vs $R_{G(ext)}$

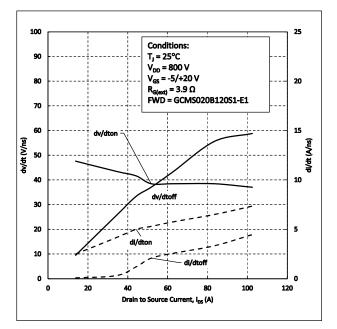
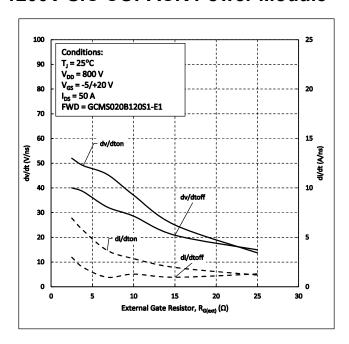


Figure 25. Switching Times vs. Drain Current

Figure 26. dv/dt and di/dt vs. Drain Current



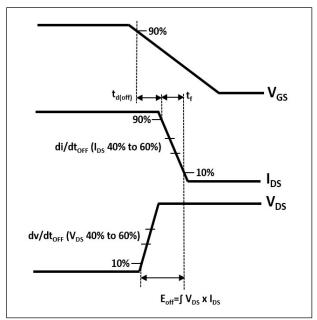


Figure 27. dv/dt and di/dt vs. $R_{\text{G(ext)}}$

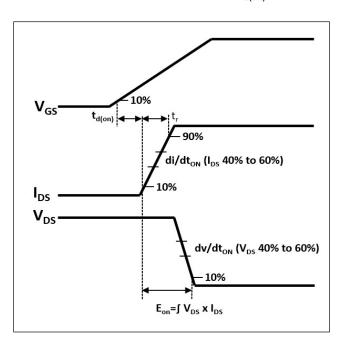


Figure 29. Turn-on Transient Definitions

Figure 28. Turn-off Transient Definitions

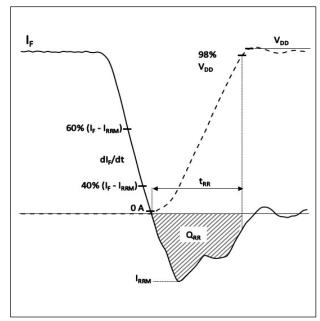
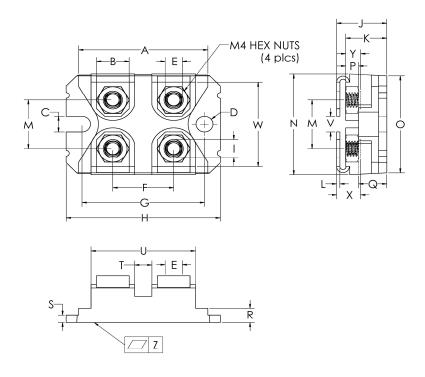


Figure 30. Reverse Recovery Definitions

Package Dimensions SOT-227



Sym	Millin	neters	Inc	hes
Sym	Min	Max	Min	Max
Α	31.67	31.90	1.247	1.256
В	7.95	8.18	0.313	0.322
С	4.14	4.24	0.163	0.167
D	4.14	4.24	0.163	0.167
E	4.14	4.24	0.163	0.167
F	14.94	15.09	0.588	0.594
G	30.15	30.25	1.187	1.191
Н	38.00	38.10	1.496	1.500
I	4.75	4.83	0.187	0.190
J	11.68	12.19	0.460	0.480
K	9.45	9.60	0.372	0.378
L	0.76	0.84	0.030	0.033
M	12.62	12.88	0.497	0.507
N	25.15	25.30	0.990	0.996
0	24.79	25.04	0.976	0.986
Р	3.02	3.15	0.119	0.124
Q	6.71	6.96	0.264	0.274
R	4.17	4.42	0.164	0.174
S	2.08	2.13	0.082	0.084
Т	3.28	3.63	0.129	0.143
U	26.75	26.90	1.053	1.059
V	3.86	4.24	0.152	0.167
W	20.55	26.90	0.809	0.814
Х	5.45	5.85	0.215	0.230
Υ	3.15	3.66	0.124	0.144
Z	0.00	0.13	0.000	0.005

GCMS020B120S1-E1

	Revision History				
Date	Revision	Notes			
4/29/2022	0.1	Preliminary release			
9/28/2022	0.2	Updated switching test data			
8/4/2023	1.0	Initial Release			

<u>Notes</u>

RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS2), as implemented March, 2013. RoHS Declarations for this product can be obtained from the Product Documentation sections of www.SemiQ.com.

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REACh substances of high concern (SVHC) information is available for this product. Since the European Chemicals Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact our office at SemiQ Headquarters in Lake Forest, California to insure you get the most up-to-date REACh SVHC Declaration. REACh banned substance information (REACh Article 67) is also available upon request.

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